


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576074	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Audrey Y Chang	<b>Art Unit</b>  2872

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
359	571, 573, 569	10/2/2008	AC

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (search note)	10/2/2008	AC

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/Audrey Y Chang/ Primary Examiner.Art Unit 2872
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